Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/736,052	STEPHENS, ADRIAN P.	
Examiner	Art Unit	

2416

AFSAR M. QURESHI

SEARCHED						
Class	Subclass	Date	Examiner			
370	200,252 203,318, 400-465	11/18/2008	ĄQ			
375	All	11/19/2008	AQ			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST,NPL,IEEE	11/18/2008	AQ
EPO,USPAT,INSPEC	11/19/2008	AQ